

Product data sheet

Product profile

1.1 General description

N-channel enhancement mode Field-Effect Transistor (FET) in a leadless ultra small DFN1006B-3 (SOT883B) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

1.2 Features and benefits

- Fast switching
- Trench MOSFET technology
- Low threshold voltage
- Ultra thin package profile with 0.37 mm height

1.3 Applications

- Relay driver
- High-speed line driver

- Low-side loadswitch
- Switching circuits

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{DS}	drain-source voltage	$T_j = 25$ °C		-	-	30	V
V_{GS}	gate-source voltage			-8	-	8	V
I _D	drain current	$V_{GS} = 4.5 \text{ V}; T_{amb} = 25 \text{ °C}$	[1]	-	-	900	mA
Static characte	eristics						
R _{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}; I_D = 200 \text{ mA}; T_j = 25 \text{ °C}$		-	420	490	mΩ

^[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 1 cm².



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		D
2	S	source	1	D
3	D	drain	2	G (EX)
			Transparent top view	s
			SOT883B (DFN1006B-3)	017aaa253

3. Ordering information

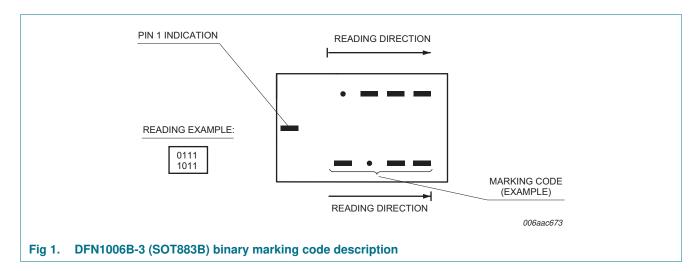
Table 3. Ordering information

Type number	Package				
	Name	Description	Version		
PMZB420UN	DFN1006B-3	Leadless ultra small plastic package; 3 solder lands; body $1.0 \times 0.6 \times 0.37$ mm	SOT883B		

4. Marking

Table 4. Marking codes

Type number	Marking code
PMZB420UN	0000 1010



5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{DS}	drain-source voltage	$T_j = 25 ^{\circ}C$		-	30	V
V_{GS}	gate-source voltage			-8	8	V
I _D	drain current	$V_{GS} = 4.5 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}$	<u>[1]</u>	-	900	mA
		$V_{GS} = 4.5 \text{ V}; T_{amb} = 100 \text{ °C}$	<u>[1]</u>	-	570	mA
I_{DM}	peak drain current	T_{amb} = 25 °C; single pulse; $t_p \le 10 \mu s$		-	3.6	Α
P _{tot}	total power dissipation	T _{amb} = 25 °C	[2]	-	360	mW
			[1]	-	715	mW
		T _{sp} = 25 °C		-	2700	mW
Tj	junction temperature			-55	150	°C
T _{amb}	ambient temperature			-55	150	°C
T _{stg}	storage temperature			-65	150	°C
Source-dra	in diode					
Is	source current	T _{amb} = 25 °C	<u>[1]</u>	-	670	mA

- [1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 1 cm².
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

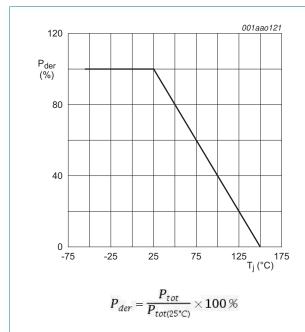


Fig 2. Normalized total power dissipation as a function of junction temperature

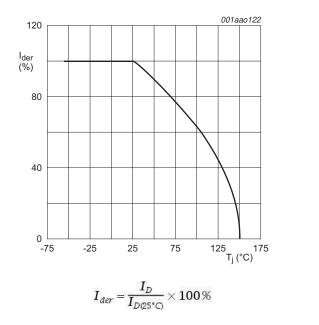
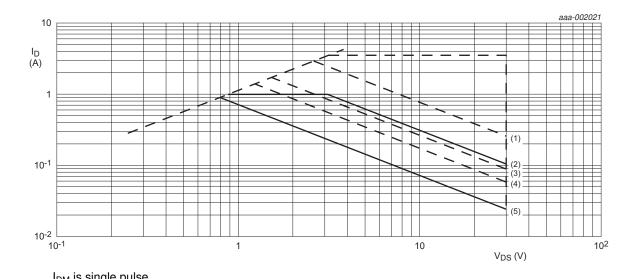


Fig 3. Normalized continuous drain current as a function of junction temperature



I_{DM} is single pulse

- (1) $t_p = 1 \text{ ms}$
- (2) DC; $T_{sp} = 25 \, ^{\circ}C$
- (3) $t_p = 10 \text{ ms}$
- $(4) t_p = 100 ms$
- (5) DC; T_{amb} = 25 °C; drain mounting pad 1 cm²

Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source Fig 4. voltage

Thermal characteristics

Table 6. **Thermal characteristics**

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance	in free air	<u>[1]</u>	-	305	360	K/W
	from junction to ambient		[2]	-	150	175	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point			-	-	40	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm².

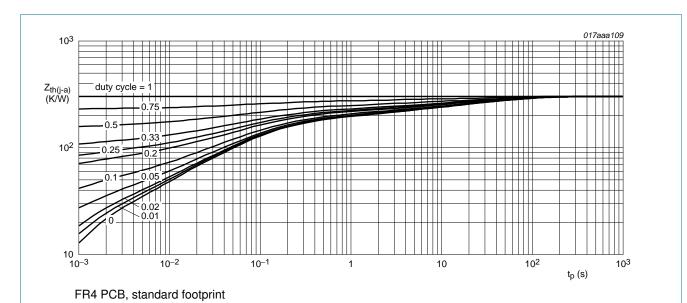


Fig 5. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

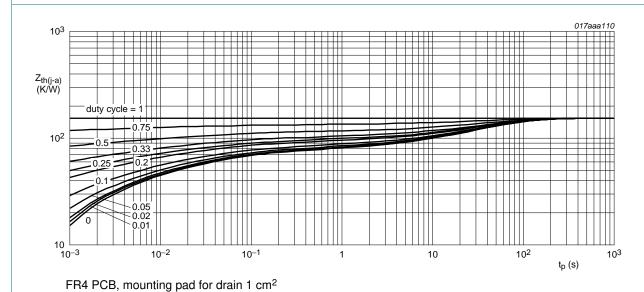
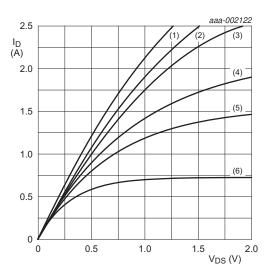


Fig 6. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

7. Characteristics

Table 7. Characteristics

Table 7.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 10 \mu A; V_{GS} = 0 V; T_j = 25 °C$	30	-	-	V
V_{GSth}	gate-source threshold voltage	$I_D = 250 \ \mu A; \ V_{DS} = V_{GS}; \ T_j = 25 \ ^{\circ}C$	0.45	0.7	0.95	V
I _{DSS}	drain leakage current	$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	1	μΑ
		$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$	-	-	100	μΑ
I _{GSS}	gate leakage current	$V_{GS} = 8 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	0.1	μΑ
		$V_{GS} = -8 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	0.1	μΑ
R _{DSon}	drain-source on-state	$V_{GS} = 4.5 \text{ V}; I_D = 200 \text{ mA}; T_j = 25 \text{ °C}$	-	420	490	mΩ
1	resistance	$V_{GS} = 4.5 \text{ V}; I_D = 200 \text{ mA}; T_j = 150 \text{ °C}$	-	714	833	mΩ
		$V_{GS} = 2.5 \text{ V}; I_D = 100 \text{ mA}; T_j = 25 \text{ °C}$	-	490	590	mΩ
		$V_{GS} = 1.8 \text{ V}; I_D = 75 \text{ mA}; T_j = 25 \text{ °C}$	-	580	760	mΩ
9 _{fs}	forward transconductance	$V_{DS} = 5 \text{ V}; I_D = 200 \text{ mA}; T_j = 25 \text{ °C}$	-	2	-	S
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$V_{DS} = 15 \text{ V}; I_D = 0.9 \text{ A}; V_{GS} = 4.5 \text{ V};$	-	0.75	0.98	nC
Q_{GS}	gate-source charge	T _j = 25 °C	-	0.05	-	nC
Q_{GD}	gate-drain charge		-	0.16	-	nC
C _{iss}	input capacitance	$V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}; V_{GS} = 0 \text{ V};$	-	43	65	pF
C _{oss}	output capacitance	T _j = 25 °C	-	7.7	-	pF
C_{rss}	reverse transfer capacitance		-	4.8	-	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 15 \text{ V}; R_L = 15 \Omega; V_{GS} = 10 \text{ V};$	-	4	8	ns
t _r	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 °C$	-	7.5	-	ns
t _{d(off)}	turn-off delay time		-	18	36	ns
t _f	fall time		-	4.5	-	ns
Source-d	rain diode					
V_{SD}	source-drain voltage	$I_S = 300 \text{ mA}$; $V_{GS} = 0 \text{ V}$; $T_i = 25 \text{ °C}$	-	0.76	1.2	٧



(1)
$$V_{GS} = 4.5 \text{ V}$$

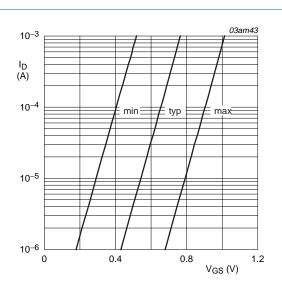
(2)
$$V_{GS} = 3.0 \text{ V}$$

(3)
$$V_{GS} = 2.5 \text{ V}$$

(4)
$$V_{GS} = 1.8 \text{ V}$$

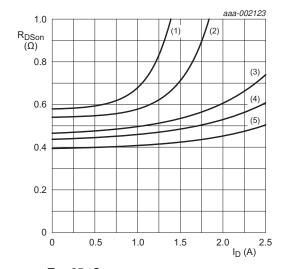
$$(5) V_{GS} = 1.5 V$$





$$T_j = 25^{\circ}C; V_{DS} = 5V$$

Fig 8. Subthreshold drain current as a function of gate-source voltage



 $T_j = 25 \, ^{\circ}C$

(1)
$$V_{GS} = 1.8 \text{ V}$$

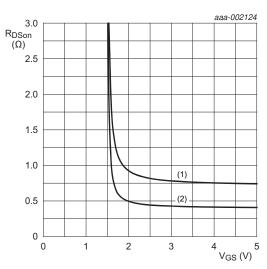
(2)
$$V_{GS} = 2.0 \text{ V}$$

(3)
$$V_{GS} = 2.5 \text{ V}$$

(4)
$$V_{GS} = 3.0 \text{ V}$$

(5)
$$V_{GS} = 4.5 \text{ V}$$

Fig 9. Drain-source on-state resistance as a function of drain current; typical values

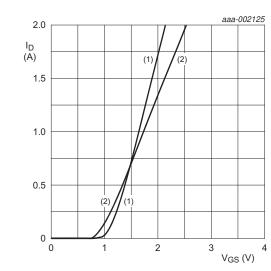


 $I_D = 800 \text{ mA}$

(1)
$$T_j = 150 \, ^{\circ}C$$

(2)
$$T_i = 25 \, ^{\circ}C$$

Fig 10. Drain-source on-state resistance as a function of gate-source voltage; typical values



 $V_{DS} > I_D \times R_{DSon}$

(1)
$$T_i = 25 \, ^{\circ}C$$

(2)
$$T_i = 150 \, ^{\circ}\text{C}$$

Fig 11. Transfer characteristics: drain current as a function of gate-source voltage; typical values

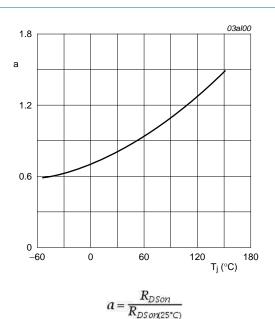


Fig 12. Normalized drain-source on-state resistance

factor as a function of junction temperature

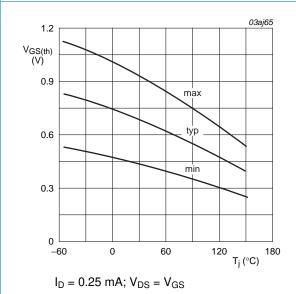
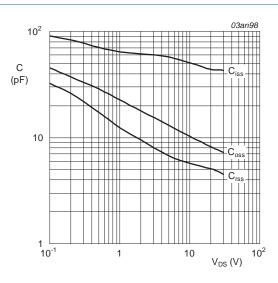
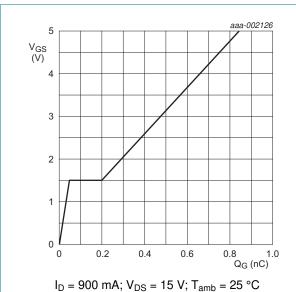


Fig 13. Gate-source threshold voltage as a function of junction temperature



 $V_{GS} = 0V; f = 1MHz$

Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



V_{GS}(th)
V_{GS}

Q_{GS1}
Q_{GS2}
Q_G(tot)

003aaa508

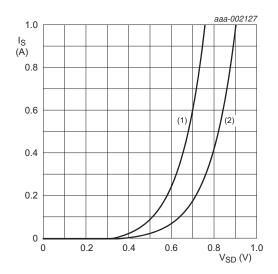
 I_D

Fig 15. Gate-source voltage as a function of gate charge; typical values

Fig 16. Gate charge waveform definitions

 V_{DS}

V_{GS(pl)}

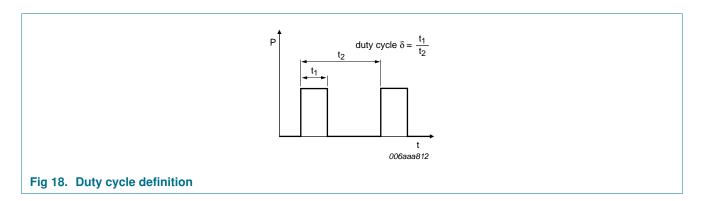


 $V_{GS} = 0 V$ (1) $T_j = 150 \, ^{\circ}C$

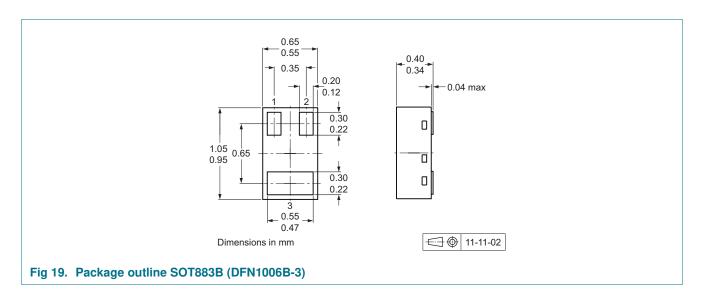
(2) $T_j = 25 \, {}^{\circ}\text{C}$

Fig 17. Source current as a function of source-drain voltage; typical values

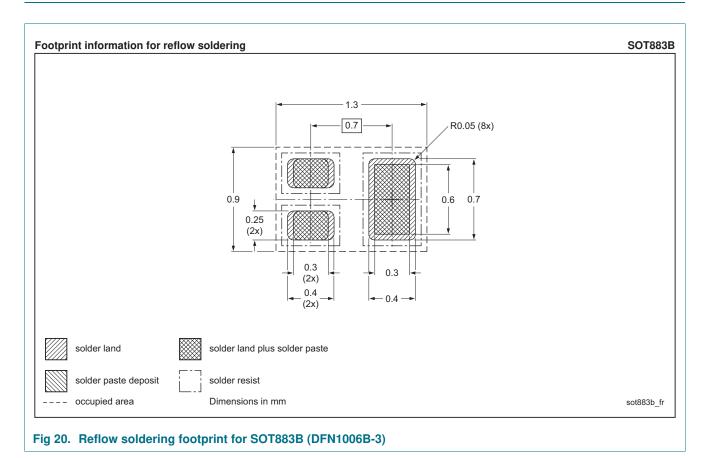
8. Test information



9. Package outline



10. Soldering





11. Revision history

Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PMZB420UN v.1	20120511	Product data sheet	-	-

12. Legal information

12.1 Data sheet status

Document status[1] [2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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PMZB420UN

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NXP Semiconductors PMZB420UN

30 V, single N-channel Trench MOSFET

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